

C2M1000170J

Silicon Carbide Power MOSFET

C2M™ MOSFET Technology

N-Channel Enhancement Mode

$$V_{DS} = 1700 \text{ V}$$

$$I_D @ 25^\circ\text{C} = 5.3 \text{ A}$$

$$R_{DS(on)} = 1.0 \Omega$$

Features

- High blocking voltage with low $R_{DS(on)}$
- Easy to parallel and simple to drive
- Low parasitic inductance
- Separate driver source pin
- Ultra-low drain-gate capacitance
- Halogen Free, RoHS compliant

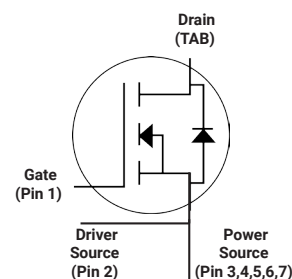
Benefits

- Higher system efficiency
- Smooth switching waveforms
- Reduced cooling requirements
- Increased system reliability

Applications

- Auxiliary power supplies
- Switch Mode Power Supplies
- High-voltage capacitive loads

Package



Part Number	Package
C2M1000170J	7L D2PAK

Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1700	V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
V_{GSop}	Gate - Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	5.3	A	$V_{GS} = 20 \text{ V}, T_C = 25^\circ\text{C}$	Fig. 19
		3.6		$V_{GS} = 20 \text{ V}, T_C = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	6.0	A	Pulse width t_p limited by T_{Jmax}	Fig. 22
P_D	Power Dissipation	78	W	$T_C = 25^\circ\text{C}, T_J = 150^\circ\text{C}$	Fig. 20
T_J, T_{stg}	Operating Junction and Storage Temperature	-55 to +150	$^\circ\text{C}$		
T_L	Solder Temperature	260	$^\circ\text{C}$	1.6mm (0.063") from case for 10s	

Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1700			V	V _{GS} = 0 V, I _D = 100 μA	
V _{GS(th)}	Gate Threshold Voltage	2.0	2.6	4	V	V _{DS} = V _{GS} , I _D = 0.5 mA	Fig. 11
			2.1		V	V _{DS} = V _{GS} , I _D = 0.5 mA, T _J = 150 °C	
I _{DSS}	Zero Gate Voltage Drain Current		1	100	μA	V _{DS} = 1.7 kV, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current			250	nA	V _{GS} = 20 V, V _{DS} = 0 V	
R _{DS(on)}	Drain-Source On-State Resistance		1.0	1.4	Ω	V _{GS} = 20 V, I _D = 2 A	Fig. 4,5,6
			2.0			V _{GS} = 20 V, I _D = 2 A, T _J = 150 °C	
g _{fs}	Transconductance		0.82		S	V _{DS} = 20 V, I _{DS} = 2 A	Fig. 7
			0.81			V _{DS} = 20 V, I _{DS} = 2 A, T _J = 150 °C	
C _{iss}	Input Capacitance		200		pF	V _{GS} = 0 V	Fig. 17,18
C _{oss}	Output Capacitance		12			V _{DS} = 1000 V	
C _{rss}	Reverse Transfer Capacitance		1.3			f = 1 MHz	
E _{oss}	C _{oss} Stored Energy		7		μJ	V _{AC} = 25 mV	Fig 16
E _{ON}	Turn-On Switching Energy		31		μJ	V _{DS} = 1.2 kV, V _{GS} = -5/20 V	Fig. 26
E _{OFF}	Turn Off Switching Energy		10			I _D = 2 A, R _{G(ext)} = 2.5 Ω, L = 1368 μH, T _J = 150 °C	
t _{d(on)}	Turn-On Delay Time		4		ns	V _{DD} = 1.2 kV, V _{GS} = -5/20 V I _D = 2 A, R _{G(ext)} = 2.5 Ω, R _L = 600 Ω Timing relative to V _{DS} Per IEC60747-8-4 pg 83	Fig. 27
t _r	Rise Time		4.8				
t _{d(off)}	Turn-Off Delay Time		10.8				
t _f	Fall Time		40.4				
R _{G(int)}	Internal Gate Resistance		24.8		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q _{gs}	Gate to Source Charge		4.7		nC	V _{DS} = 1.2 kV, V _{GS} = -5/20 V I _D = 2 A Per IEC60747-8-4 pg 21	Fig. 12
Q _{gd}	Gate to Drain Charge		5.4				
Q _g	Total Gate Charge		13				

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	3.8		V	V _{GS} = -5 V, I _{SD} = 1 A, T _J = 25 °C	Fig. 8, 9, 10
		3.3		V	V _{GS} = -5 V, I _{SD} = 1 A, T _J = 150 °C	
I _S	Continuous Diode Forward Current		4	A	T _c = 25 °C	Note 1
t _{rr}	Reverse Recovery Time	20		ns	V _{GS} = -5 V, I _{SD} = 2 A, T _J = 25 °C V _R = 1.2 kV dif/dt = 1200 A/μs	Note 1
Q _{rr}	Reverse Recovery Charge	24		nC		
I _{rrm}	Peak Reverse Recovery Current	6.5		A		

Note (1): When using SiC Body Diode the maximum recommended V_{GS} = -5V

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
R _{θJC}	Thermal Resistance from Junction to Case	1.5	1.6	°C/W		Fig. 21
R _{θJA}	Thermal Resistance from Junction to Ambient		40			

Typical Performance

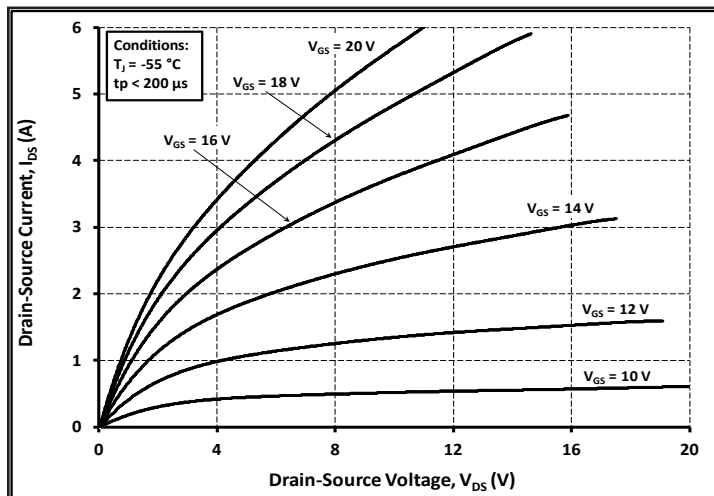


Figure 1. Output Characteristics $T_J = -55\text{ }^{\circ}\text{C}$

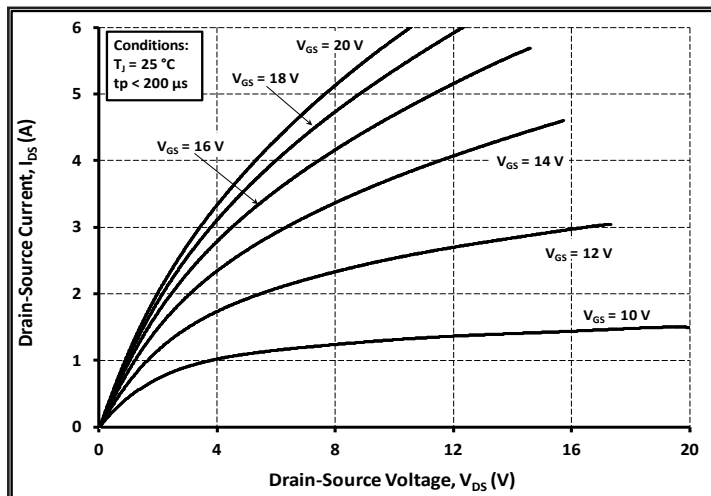


Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

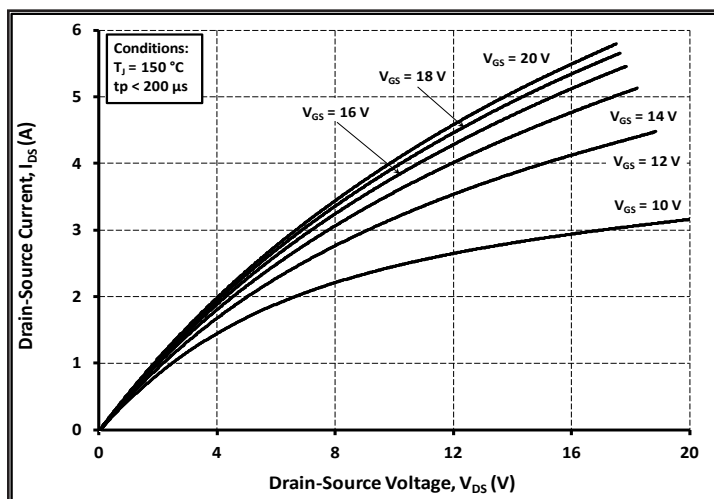


Figure 3. Output Characteristics $T_J = 150\text{ }^{\circ}\text{C}$

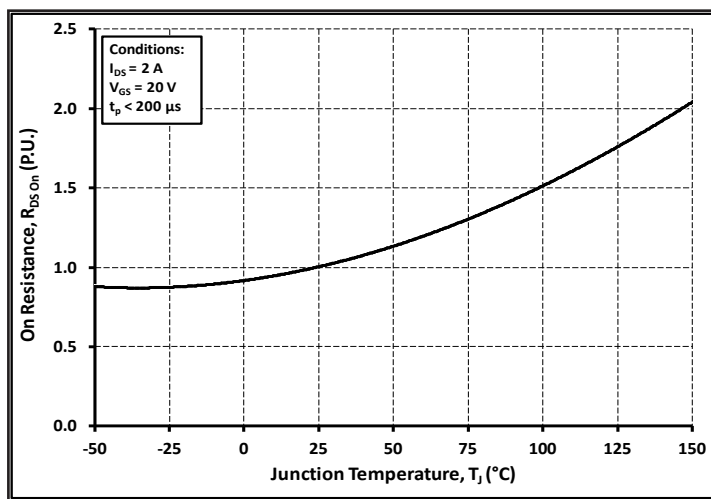


Figure 4. Normalized On-Resistance vs. Temperature

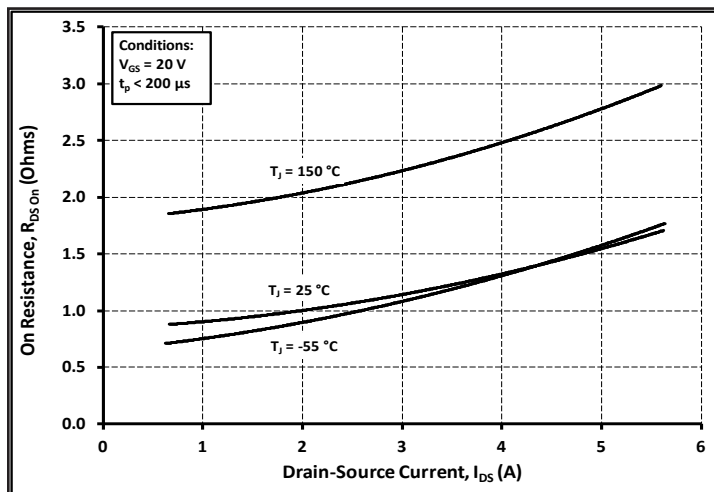


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

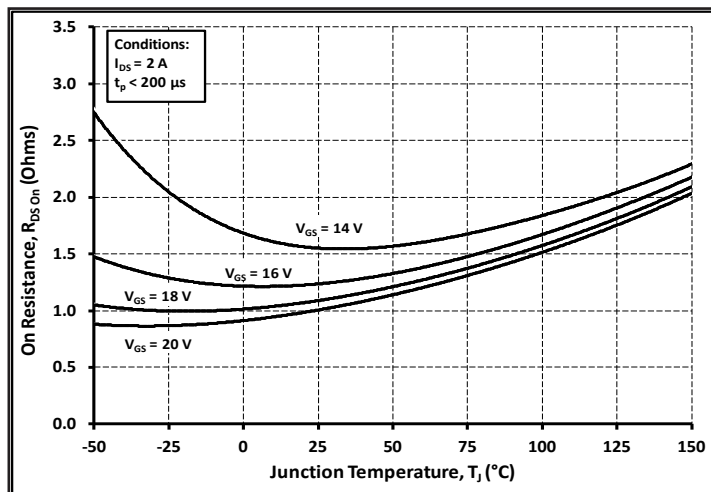


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

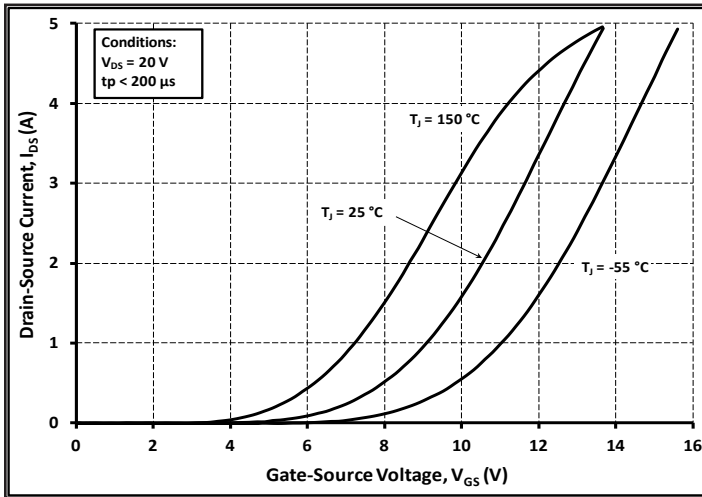


Figure 7. Transfer Characteristic for Various Junction Temperatures

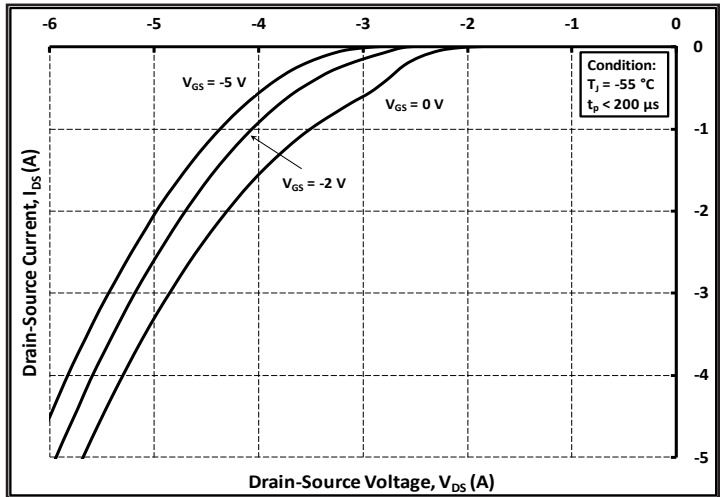


Figure 8. Body Diode Characteristic at $-55\text{ }^{\circ}\text{C}$

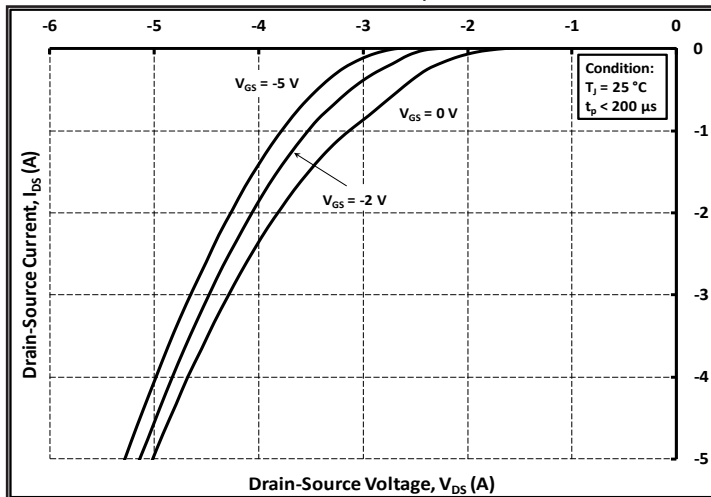


Figure 9. Body Diode Characteristic at $25\text{ }^{\circ}\text{C}$

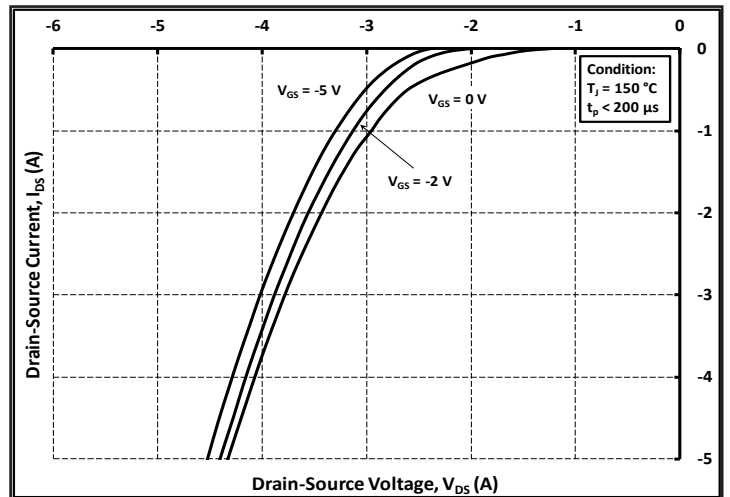


Figure 10. Body Diode Characteristic at $150\text{ }^{\circ}\text{C}$

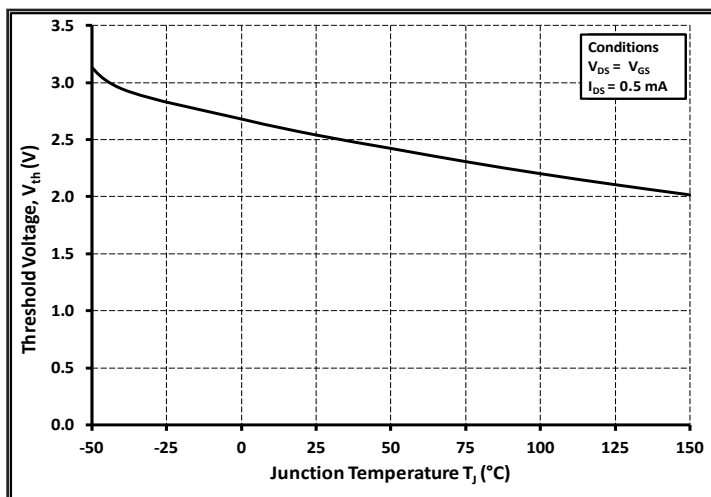


Figure 11. Threshold Voltage vs. Temperature

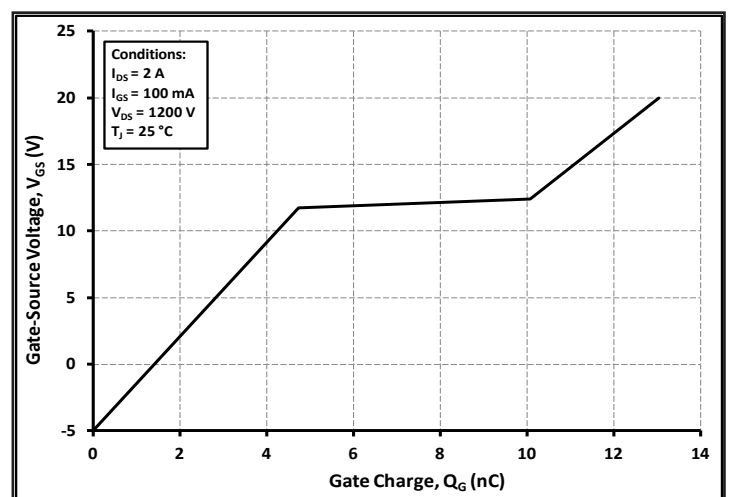


Figure 12. Gate Charge Characteristics

Typical Performance

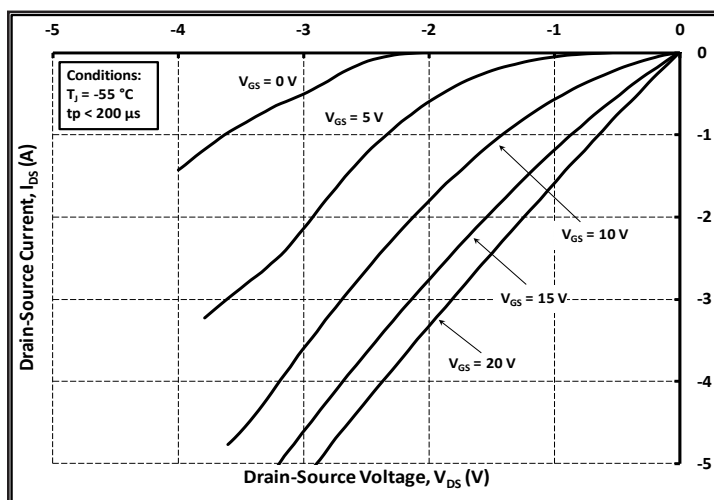


Figure 13. 3rd Quadrant Characteristic at $-55\text{ }^{\circ}\text{C}$

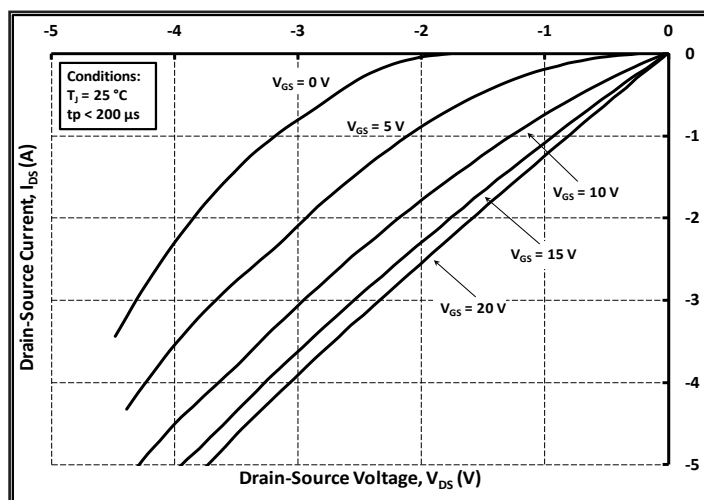


Figure 14. 3rd Quadrant Characteristic at $25\text{ }^{\circ}\text{C}$

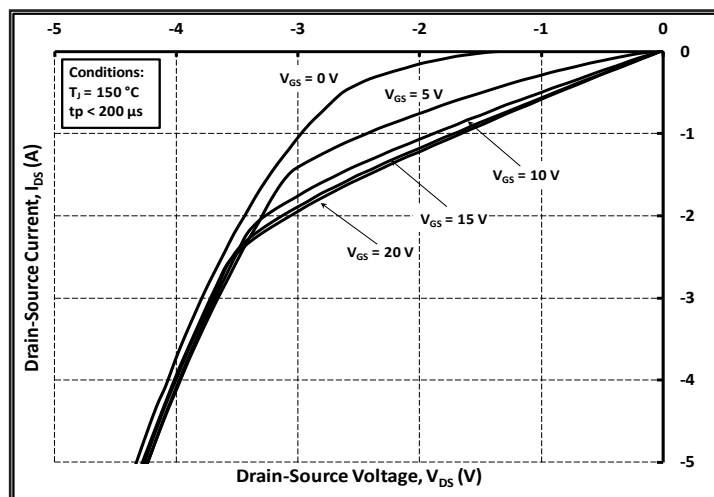


Figure 15. 3rd Quadrant Characteristic at $150\text{ }^{\circ}\text{C}$

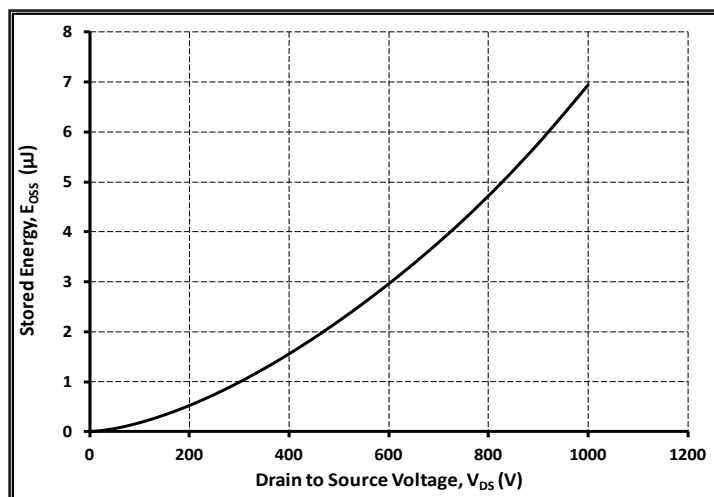


Figure 16. Output Capacitor Stored Energy

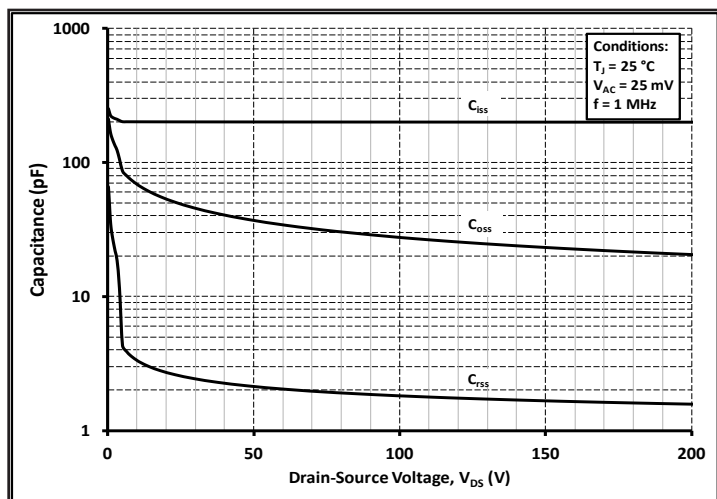


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

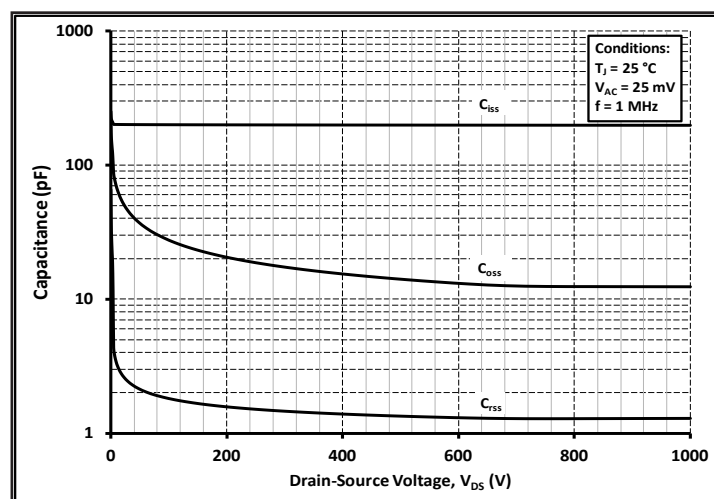


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)

Typical Performance

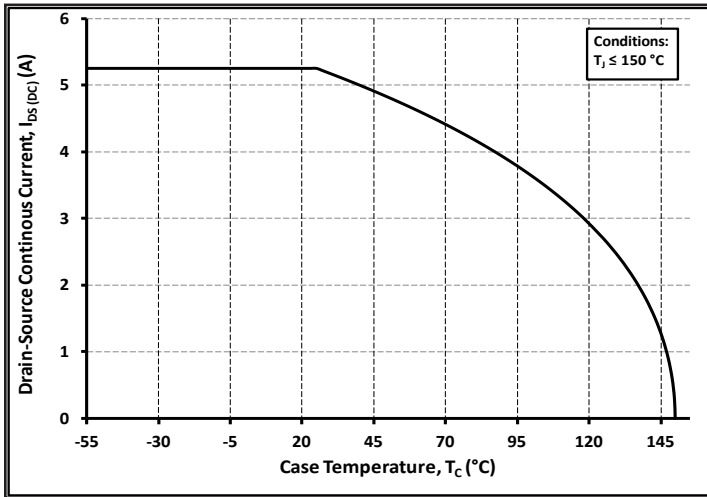


Figure 19. Continuous Drain Current Derating vs. Case Temperature

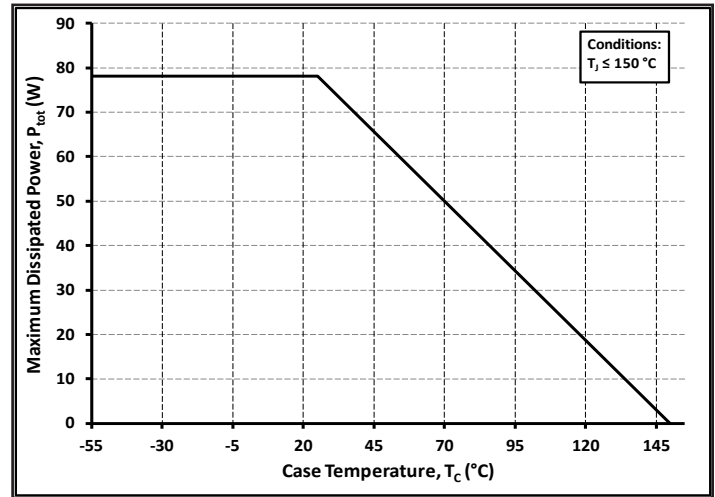


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

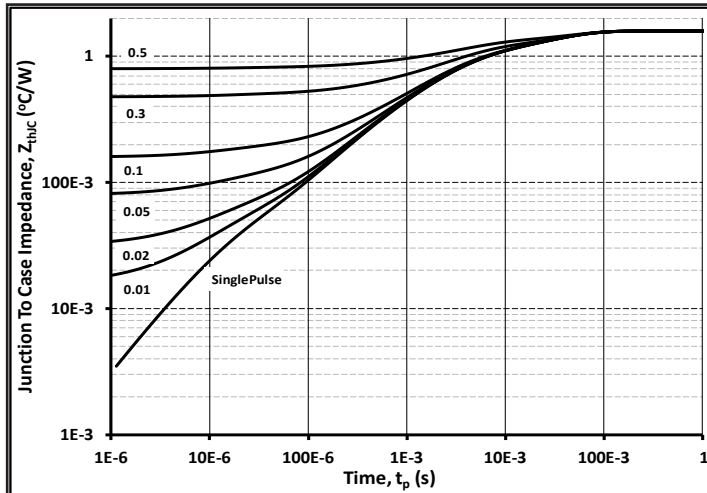


Figure 21. Transient Thermal Impedance (Junction - Case)

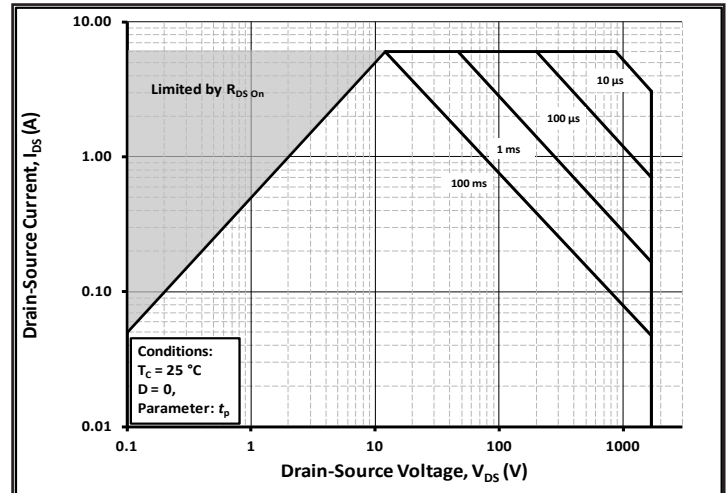


Figure 22. Safe Operating Area

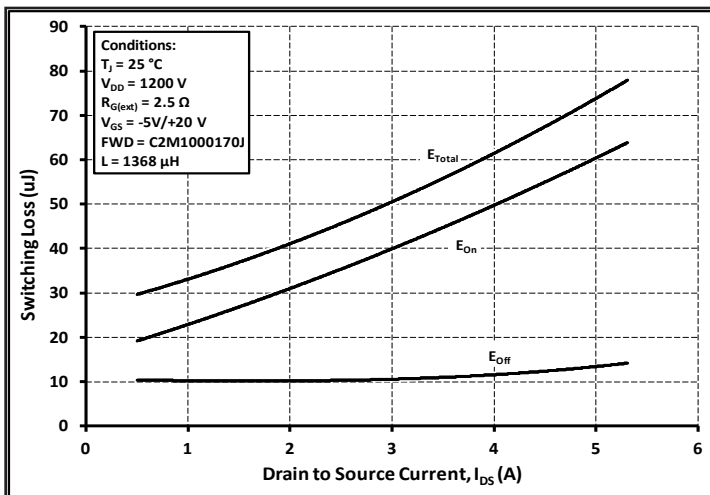


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 1200\text{ V}$)

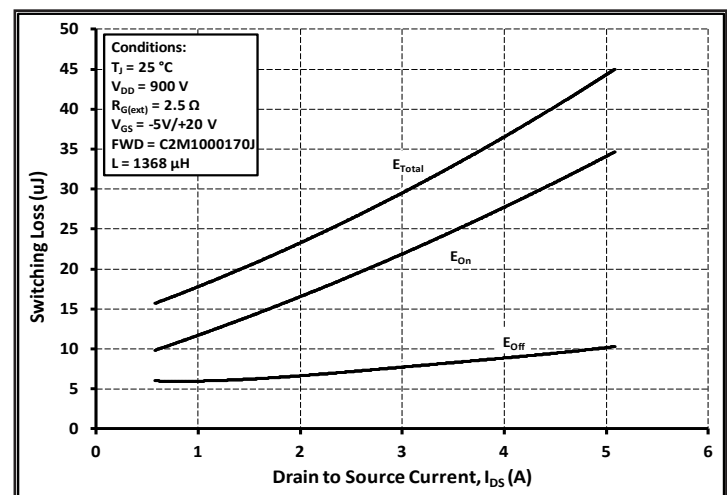


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 900\text{ V}$)

Typical Performance

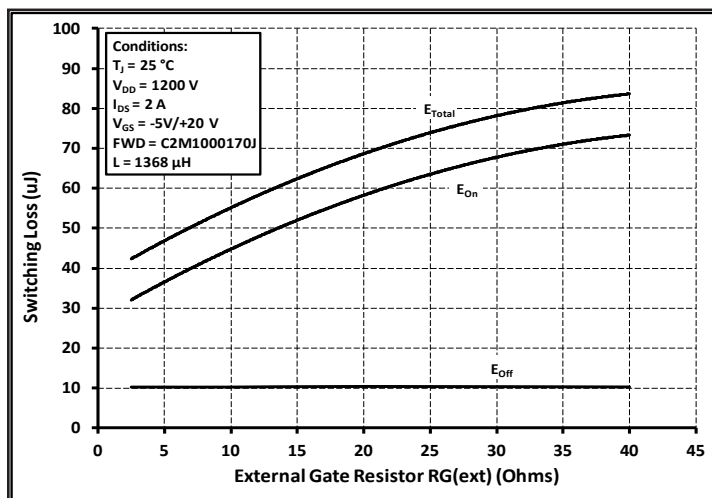


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(\text{ext})}$

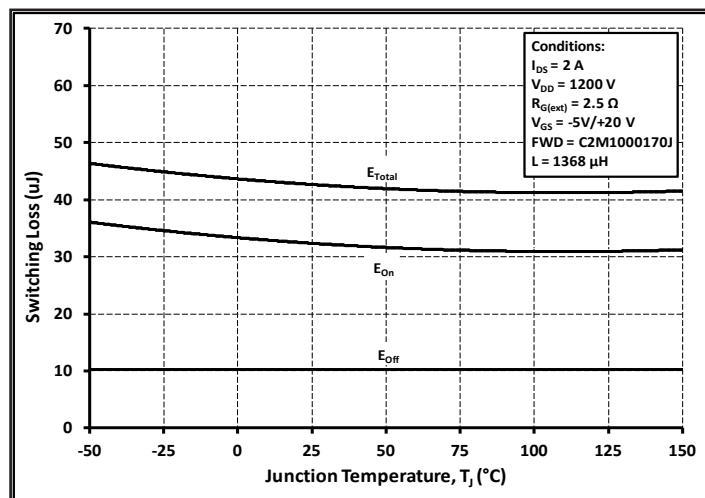


Figure 26. Clamped Inductive Switching Energy vs. Temperature

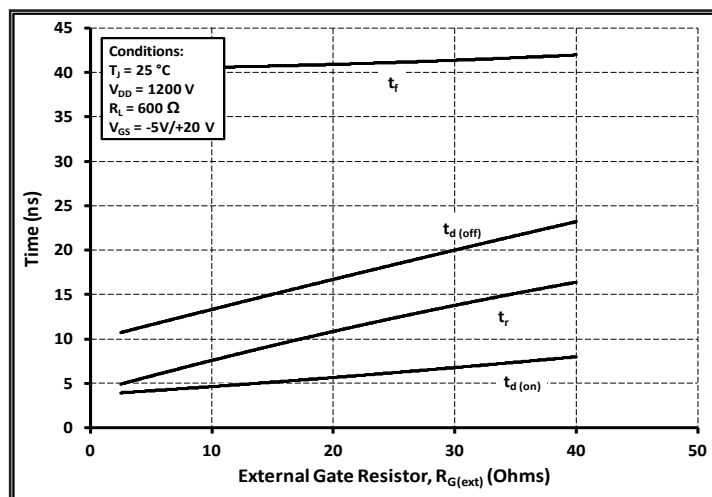


Figure 27. Switching Times vs. $R_{G(\text{ext})}$

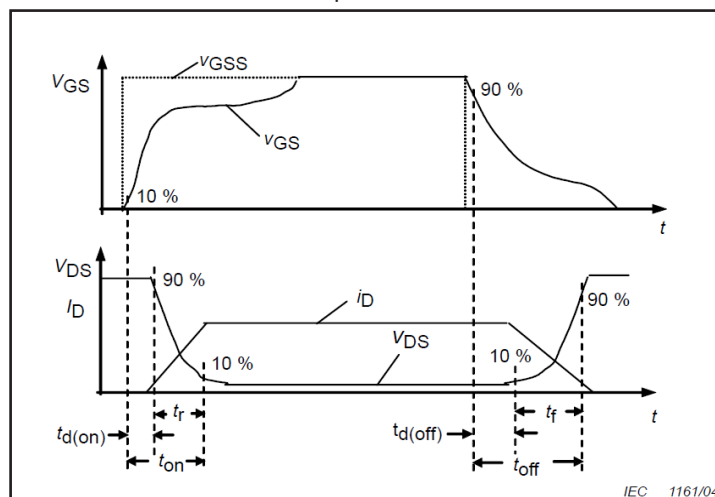


Figure 28. Switching Times Definition

Test Circuit Schematic

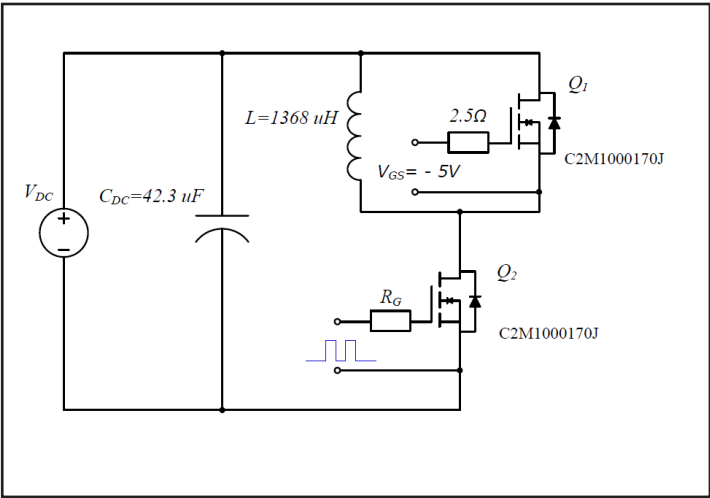


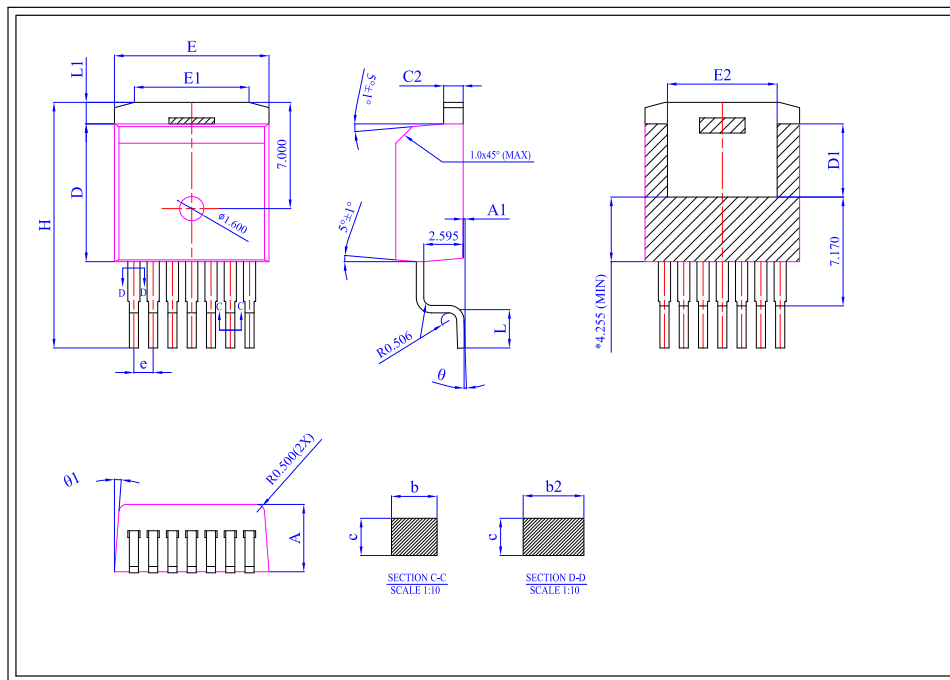
Figure 29. Clamped Inductive Switching
Waveform Test Circuit

ESD Ratings

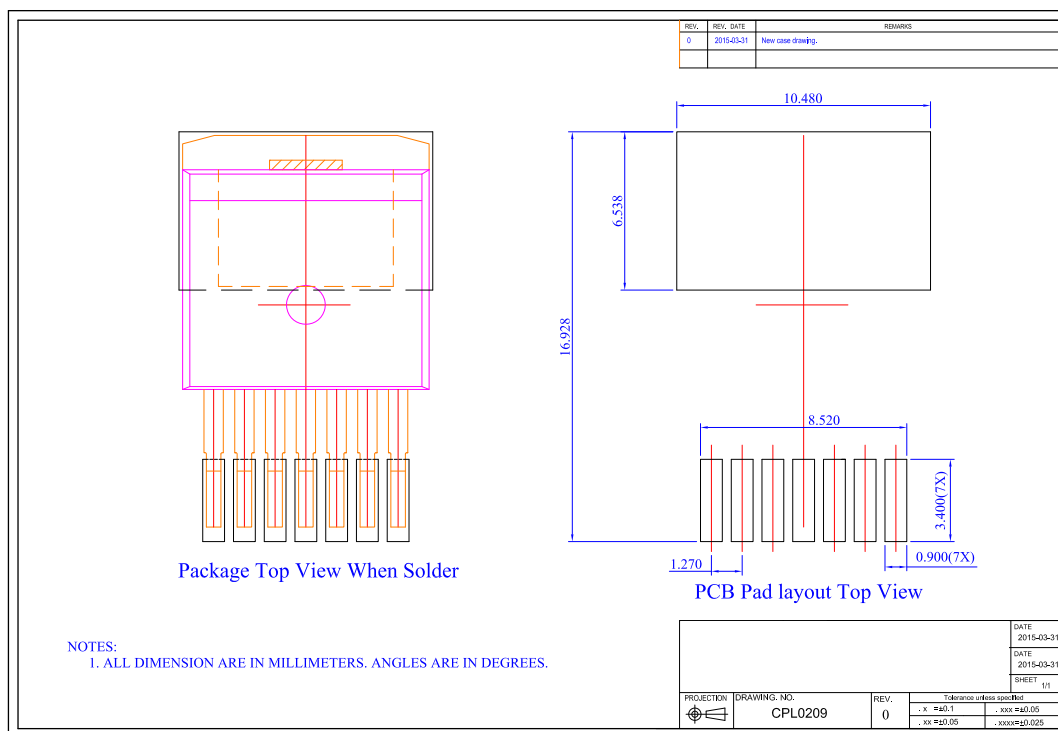
ESD Test	Total Devices Sampled	Resulting Classification
ESD-HBM	All Devices Passed 4000V	3A (>4000V)
ESD-MM	All Devices Passed 200V	A (>200V)
ESD-CDM	All Devices Passed 1000V	IV (>1000V)

Package Dimensions

Package 7L D2PAK



Dim	All Dimensions in Millimeters		
	Min	typ	Max
A	4.300	4.435	4.570
A1	0.00	0.125	0.25
b	0.500	0.600	0.700
b2	0.600	0.800	1.000
c	0.330	0.490	0.650
C2	1.170	1.285	1.400
D	9.025	9.075	9.125
D1	4.700	4.800	4.900
E	10.130	10.180	10.230
E1	6.500	7.550	8.600
E2	6.778	7.223	7.665
e	1.27		
H	15.043	16.178	17.313
L	2.324	2.512	2.700
L1	0.968	1.418	1.868
Ø	0°	4°	8°
Ø1	4.5°	5°	5.5°



Notes

- **RoHS Compliance**
The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.
- **REACH Compliance**
REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.
- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

Related Links

- **C2M PSPIICE Models:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Isolated Gate Driver reference design:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Evaluation Board:** <http://wolfspeed.com/power/tools-and-support>
- **60W Auxiliary power supply reference design:** <http://wolfspeed.com/power/tools-and-support>

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<http://moschip.ru/get-element>

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Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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